

Notice of References Cited	Application/Control No. 10/032,711		Applicant(s)/Patent Under Reexamination LLOYD ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,711,863	01-1973	Bloom, Delwin W.	714/38
	B	US-5,359,730	10-1994	Marron, Assaf	717/169
	C	US-6,748,584	06-2004	Witchel et al.	717/136
	D	US-5,608,910	03-1997	Shimakura, Masami	718/100
	E	US-5,805,899	09-1998	Evans et al.	717/170
	F	US-5,740,405	04-1998	DeGraaf, Kevin Henry	703/22
	G	US-5,983,242	11-1999	Brown et al.	707/203
	H	US-6,415,435	07-2002	McIntyre, Joseph Herbert	717/108
	I	US-5,649,200	07-1997	Leblang et al.	717/122
	J	US-2001/0048728	12-2001	Peng, Luosheng	375/354
	K	US-6,832,373	12-2004	O'Neill, Patrick J.	717/171
	L	US-2003/0037075	02-2003	Hannigan et al.	707/500
	M	US-6,251,010	06-2001	Tajiri et al.	463/1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-10-021066	01-1998	Japan	Kawamura et al.	English version
	O	JP-05-100832	04-1993	Japan	Kuwajima	English version
	P	JP-04-171532	06-1992	Japan	Takano	English Abstract
	Q	JP-05-108319	04-1993	Japan	Morioka et al.	English version
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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